

# MOS FIELD EFFECT TRANSISTOR $\mu$ PA2590

## N- AND P-CHANNEL MOSFET FOR SWITCHING

### DESCRIPTION

The  $\mu$ PA2590 is N- and P-channel MOSFETs designed for DC/DC converters and power management applications of portable equipments.

N- and P-channel MOSFETs are assembled in one package, to contribute minimize the equipments.

### FEATURES

- 4.5 V drive available
- Low on-state resistance

N-channel  $R_{DS(on)1} = 50 \text{ m}\Omega \text{ MAX. (} V_{GS} = 10 \text{ V, } I_D = 2 \text{ A)}$

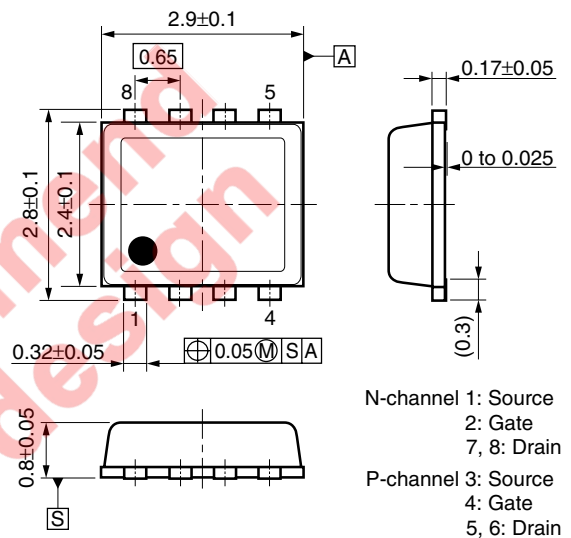
$R_{DS(on)2} = 83 \text{ m}\Omega \text{ MAX. (} V_{GS} = 4.5 \text{ V, } I_D = 2 \text{ A)}$

P-channel  $R_{DS(on)1} = 72 \text{ m}\Omega \text{ MAX. (} V_{GS} = -10 \text{ V, } I_D = -2 \text{ A)}$

$R_{DS(on)2} = 105 \text{ m}\Omega \text{ MAX. (} V_{GS} = -4.5 \text{ V, } I_D = -2 \text{ A)}$

- Built-in gate protection diode
- Small and surface mount package (8-pin VSOFF (2429))

### PACKAGE DRAWING (Unit: mm)



### ORDERING INFORMATION

PART NUMBER	LEAD PLATING	PACKING	PACKAGE
$\mu$ PA2590T1H-T1-AT <small>Note</small>	Pure Sn	8 mm embossed taping	8-pin VSOFF (2429)
$\mu$ PA2590T1H-T2-AT <small>Note</small>		3000 p/reel	

**Note** Pb-free (This product does not contain Pb in the external electrode and other parts.)

**Marking: 2590**

The information in this document is subject to change without notice. Before using this document, please confirm that this is the latest version.  
Not all products and/or types are available in every country. Please check with an NEC Electronics sales representative for availability and additional information.

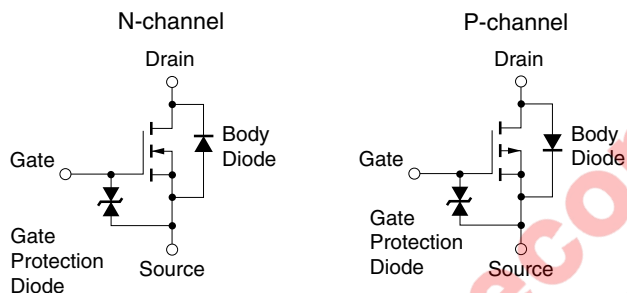
**ABSOLUTE MAXIMUM RATINGS (T<sub>A</sub> = 25°C)**

PARAMETER	SYMBOL	N-CHANNEL	P-CHANNEL	UNIT
Drain to Source Voltage (V <sub>GS</sub> = 0 V)	V <sub>DSS</sub>	30	-30	V
Gate to Source Voltage (V <sub>DS</sub> = 0 V)	V <sub>GSS</sub>	±20	∓20	V
Drain Current (DC)	I <sub>D(DC)</sub>	±4.5	∓4.5	A
Drain Current (pulse) <sup>Note1</sup>	I <sub>D(pulse)</sub>	±18	∓18	A
Total Power Dissipation (1 unit, 5 s) <sup>Note2</sup>	P <sub>T1</sub>	1.5		W
Total Power Dissipation (2 units, 5 s) <sup>Note2</sup>	P <sub>T2</sub>	1.24		W
Channel Temperature	T <sub>ch</sub>	150		°C
Storage Temperature	T <sub>stg</sub>	-55 to +150		°C

**Notes 1.** PW ≤ 10 μs, Duty Cycle ≤ 1%

**2.** Mounted on FR-4 board of 25.4 mm x 25.4 mm x 0.8 mm

**EQUIVALENT CIRCUIT**



**Remark** The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

**Caution** This product is electrostatic-sensitive device due to low ESD capability and should be handled with caution for electrostatic discharge.

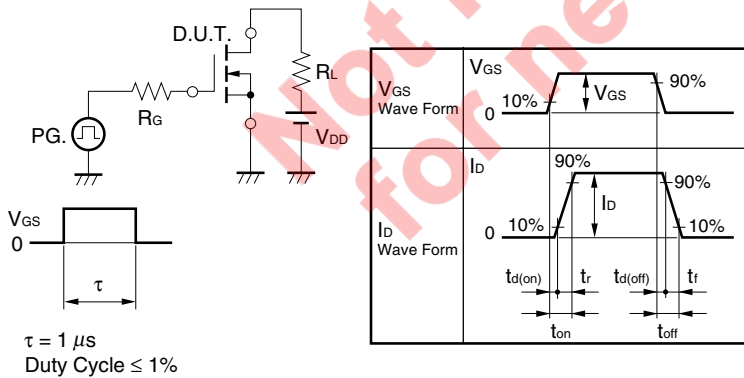
**ELECTRICAL CHARACTERISTICS (T<sub>A</sub> = 25°C)**

**N-channel MOSFET**

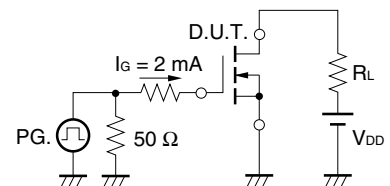
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V			1	μA
Gate Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> = ±16 V, V <sub>DS</sub> = 0 V			±10	μA
Gate to Source Cut-off Voltage	V <sub>GS(off)</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	1.0		2.5	V
Forward Transfer Admittance <b>Note</b>	y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 2 A	1			S
Drain to Source On-state Resistance <b>Note</b>	R <sub>DS(on)1</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 2 A		38	50	mΩ
	R <sub>DS(on)2</sub>	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 2 A		48	83	mΩ
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> = 10 V,		310		pF
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V,		65		pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0 MHz		27		pF
Turn-on Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 15 V, I <sub>D</sub> = 2 A,		6		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V,		2.8		ns
Turn-off Delay Time	t <sub>d(off)</sub>	R <sub>G</sub> = 6 Ω		15		ns
Fall Time	t <sub>f</sub>			2.4		ns
Total Gate Charge	Q <sub>G</sub>	V <sub>DD</sub> = 24 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 4.5 A		6.6		nC
Body Diode Forward Voltage <b>Note</b>	V <sub>F(S-D)</sub>	I <sub>F</sub> = 4.5 A, V <sub>GS</sub> = 0 V		0.9		V

**Note** Pulsed

**TEST CIRCUIT 1 SWITCHING TIME**



**TEST CIRCUIT 2 GATE CHARGE**

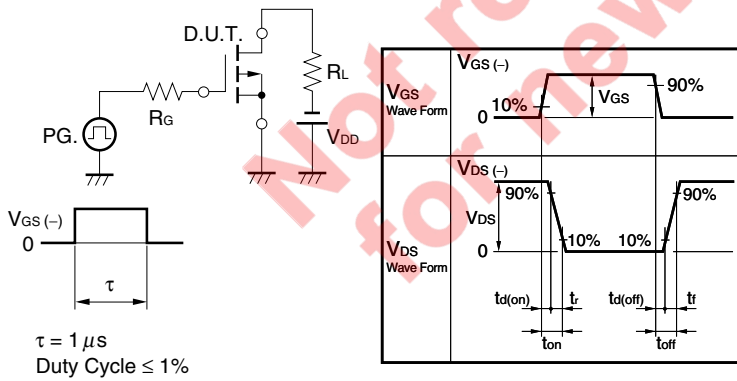


**P-channel MOSFET**

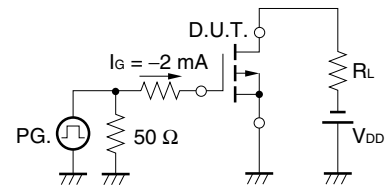
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = -30\text{ V}, V_{GS} = 0\text{ V}$			-1	$\mu\text{A}$
Gate Leakage Current	$I_{GSS}$	$V_{GS} = \mp 16\text{ V}, V_{DS} = 0\text{ V}$			$\mp 10$	$\mu\text{A}$
Gate to Source Cut-off Voltage	$V_{GS(off)}$	$V_{DS} = -10\text{ V}, I_D = -1\text{ mA}$	1.0		2.5	V
Forward Transfer Admittance <b>Note</b>	$ y_{fs} $	$V_{DS} = -10\text{ V}, I_D = -2\text{ A}$	1			S
Drain to Source On-state Resistance <b>Note</b>	$R_{DS(on)1}$	$V_{GS} = -10\text{ V}, I_D = -2\text{ A}$		56	72	$\text{m}\Omega$
	$R_{DS(on)2}$	$V_{GS} = -4.5\text{ V}, I_D = -2\text{ A}$		75	105	$\text{m}\Omega$
Input Capacitance	$C_{iss}$	$V_{DS} = -10\text{ V},$		310		$\text{pF}$
Output Capacitance	$C_{oss}$	$V_{GS} = 0\text{ V},$		78		$\text{pF}$
Reverse Transfer Capacitance	$C_{rss}$	$f = 1.0\text{ MHz}$		65		$\text{pF}$
Turn-on Delay Time	$t_{d(on)}$	$V_{DD} = -15\text{ V}, I_D = -2\text{ A},$		6.5		ns
Rise Time	$t_r$	$V_{GS} = -10\text{ V},$		3.5		ns
Turn-off Delay Time	$t_{d(off)}$	$R_G = 6\ \Omega$		33		ns
Fall Time	$t_f$			26		ns
Total Gate Charge	$Q_G$	$V_{DD} = -24\text{ V}, V_{GS} = -10\text{ V},$ $I_D = -4.5\text{ A}$		7.5		nC
Body Diode Forward Voltage <b>Note</b>	$V_{F(S-D)}$	$I_F = -4.5\text{ A}, V_{GS} = 0\text{ V}$		0.95		V

**Note** Pulsed

**TEST CIRCUIT 1 SWITCHING TIME**

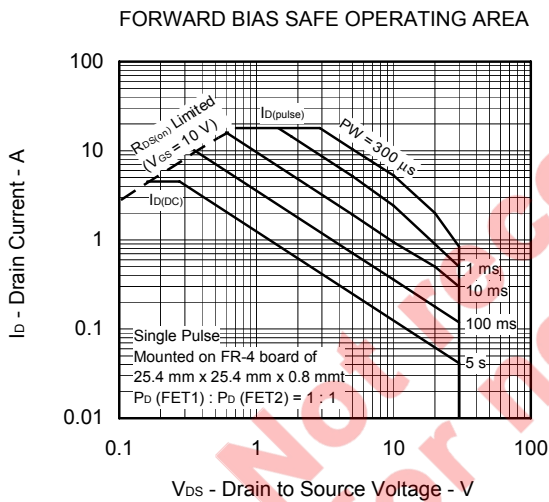
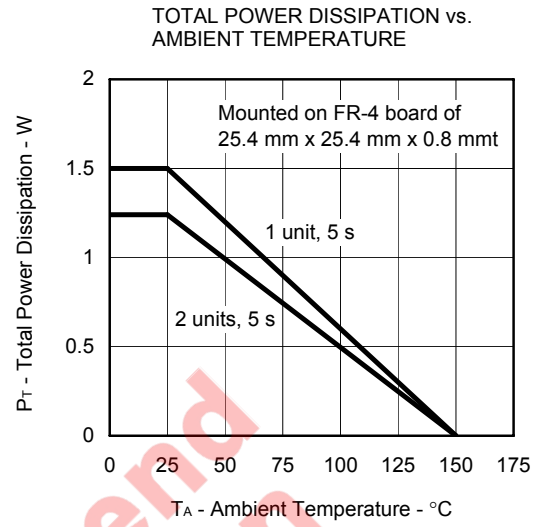
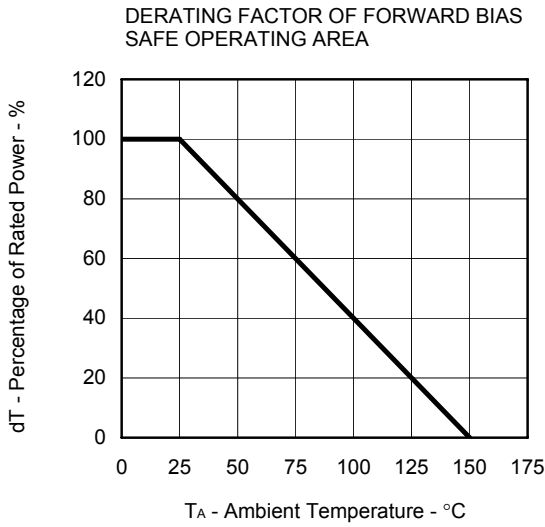


**TEST CIRCUIT 2 GATE CHARGE**

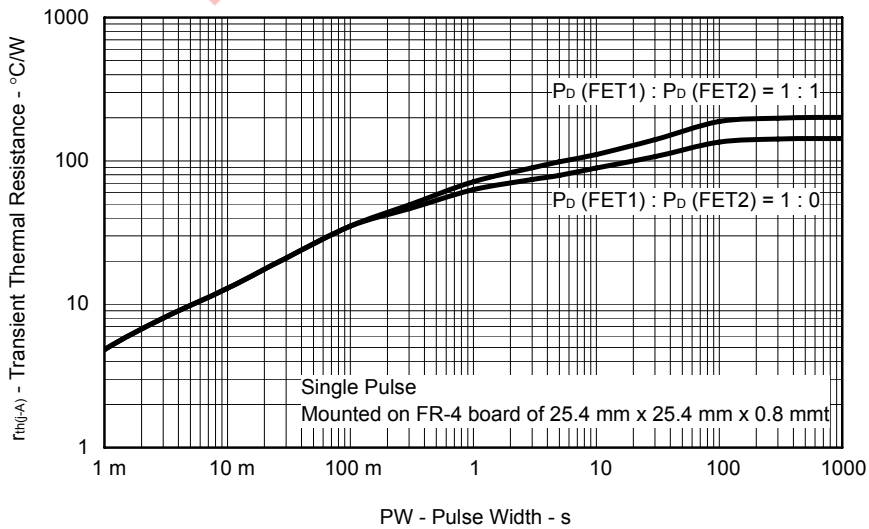


TYPICAL CHARACTERISTICS (T<sub>A</sub> = 25°C)

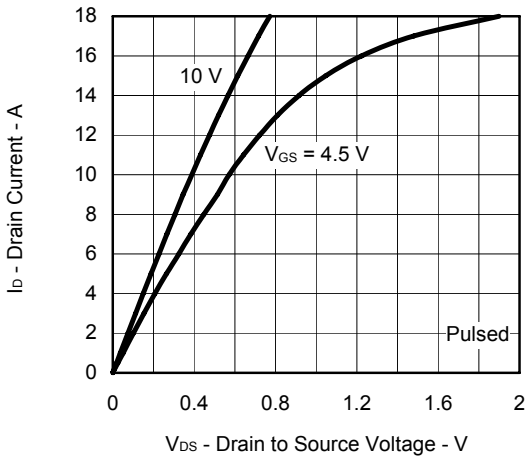
(1) N-channel MOSFET



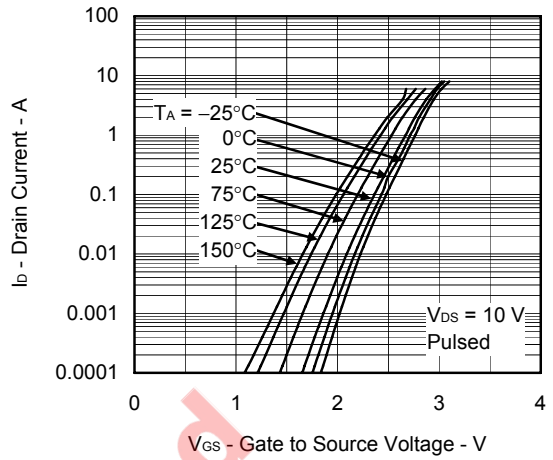
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



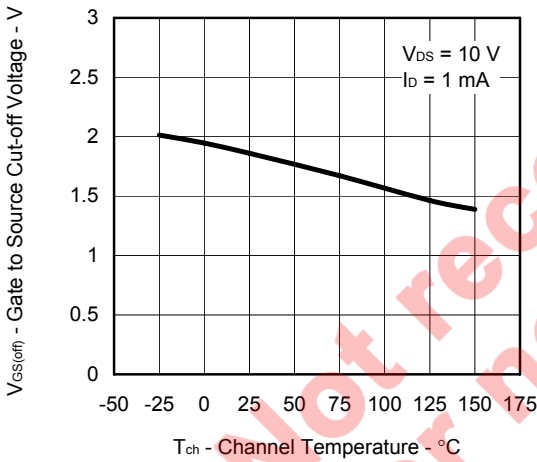
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



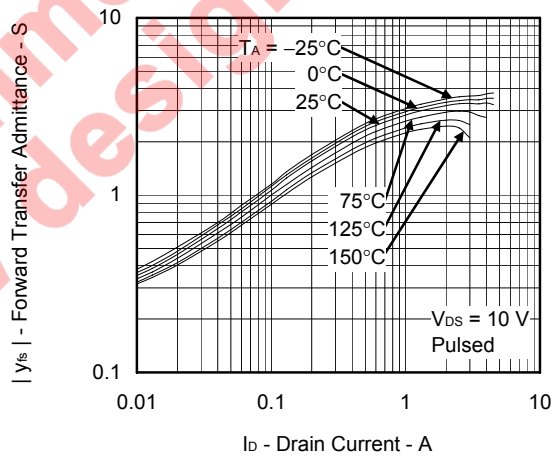
FORWARD TRANSFER CHARACTERISTICS



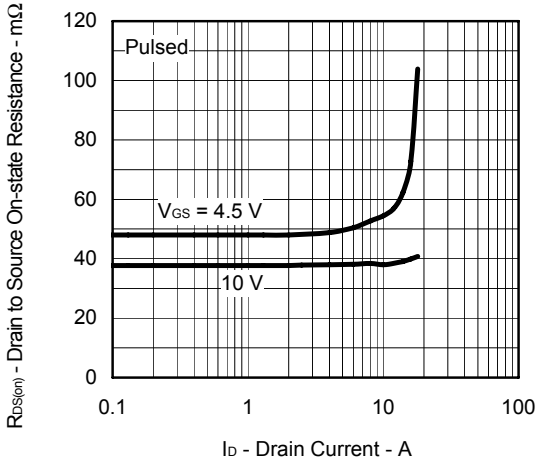
GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



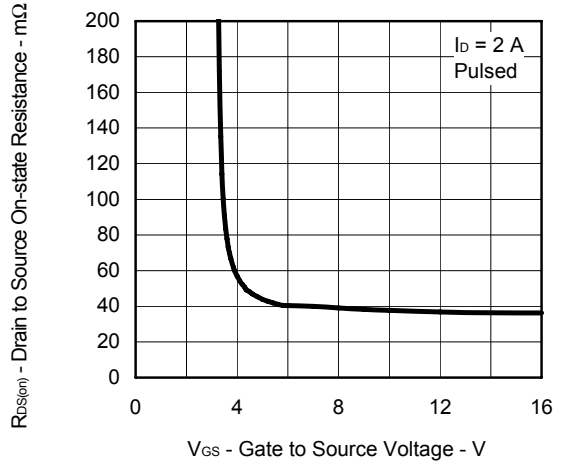
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



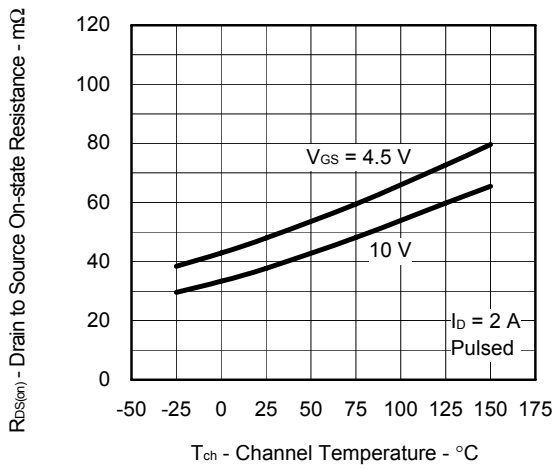
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



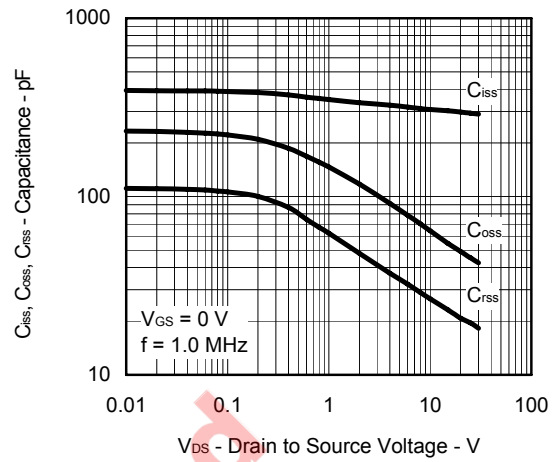
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



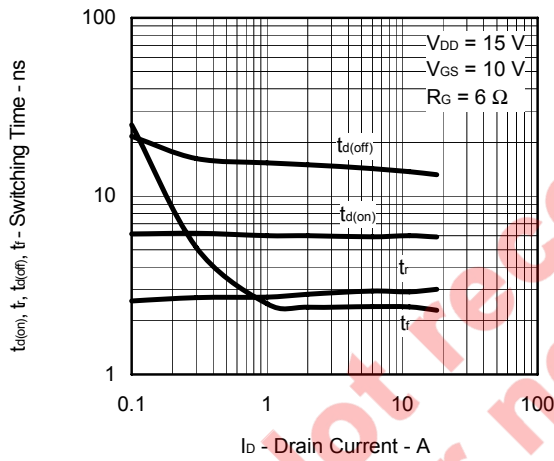
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



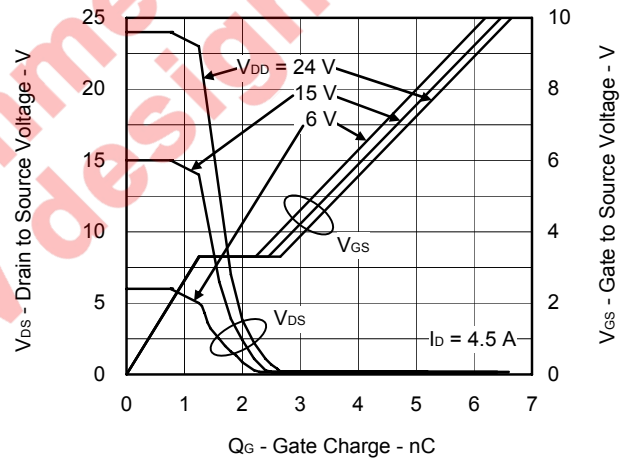
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



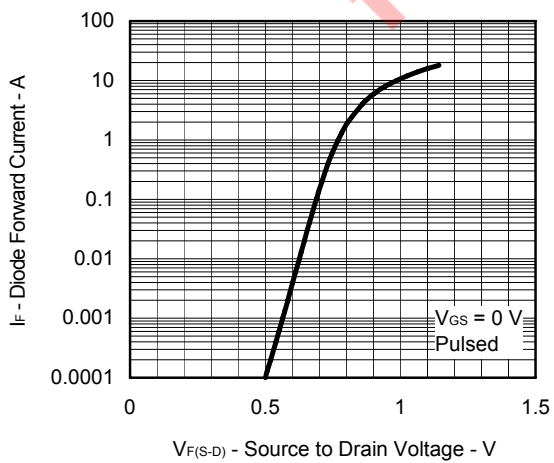
SWITCHING CHARACTERISTICS



DYNAMIC INPUT/OUTPUT CHARACTERISTICS

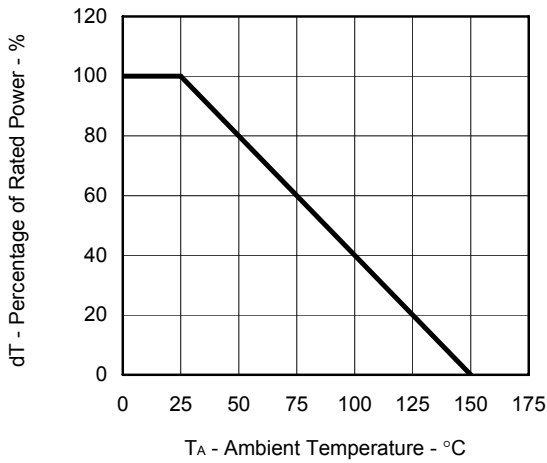


SOURCE TO DRAIN DIODE FORWARD VOLTAGE

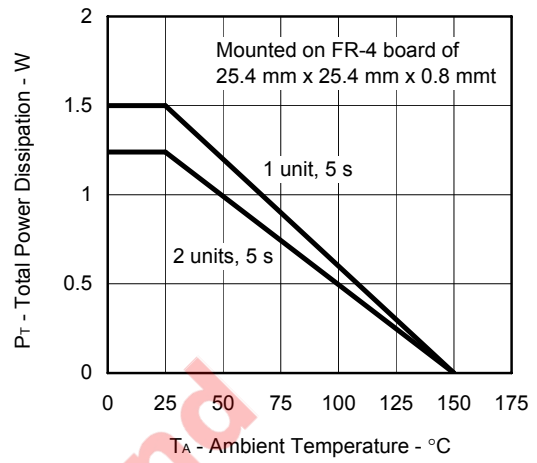


(2) P-channel MOSFET

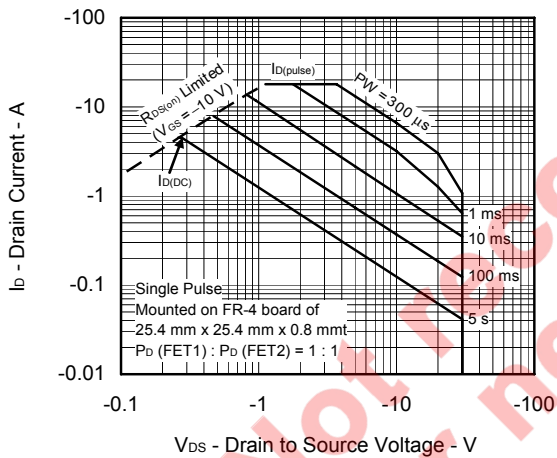
DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA



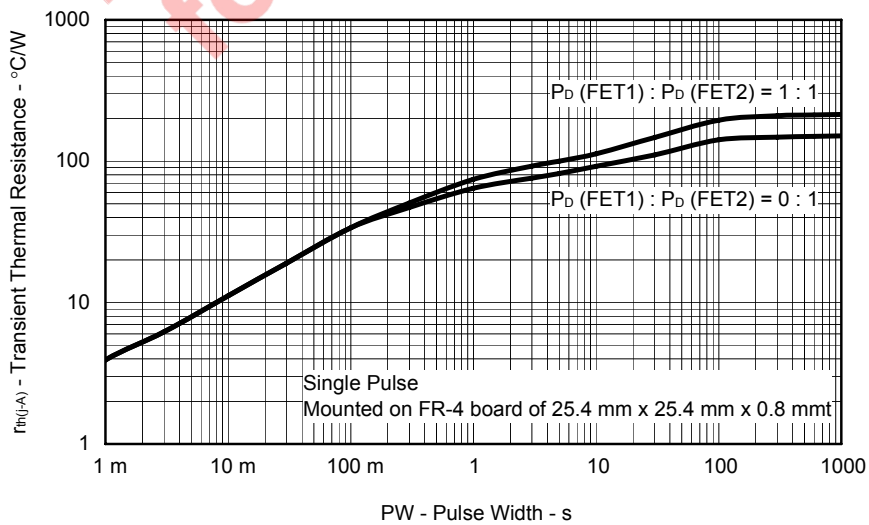
TOTAL POWER DISSIPATION vs. AMBIENT TEMPERATURE



FORWARD BIAS SAFE OPERATING AREA

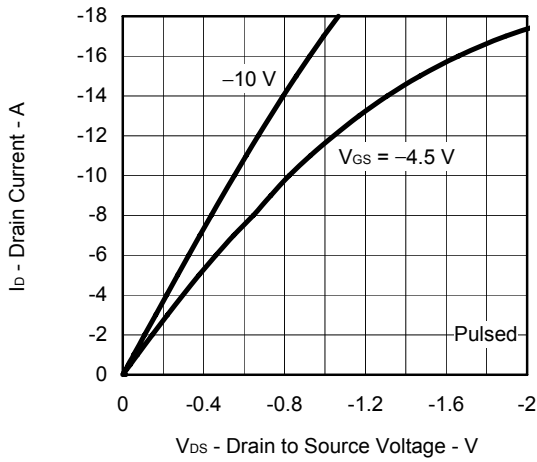


TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

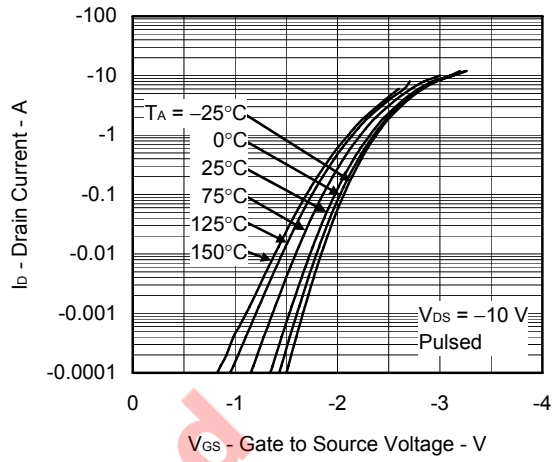




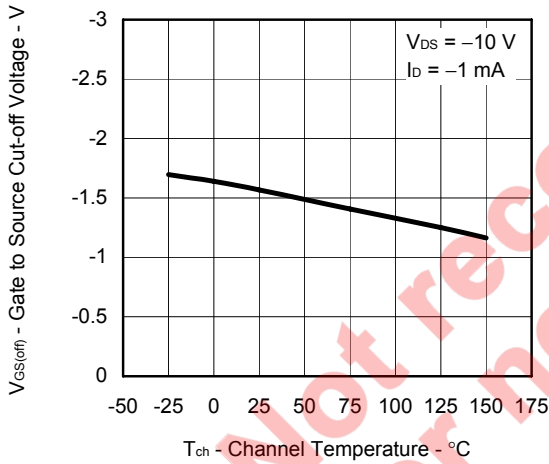
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



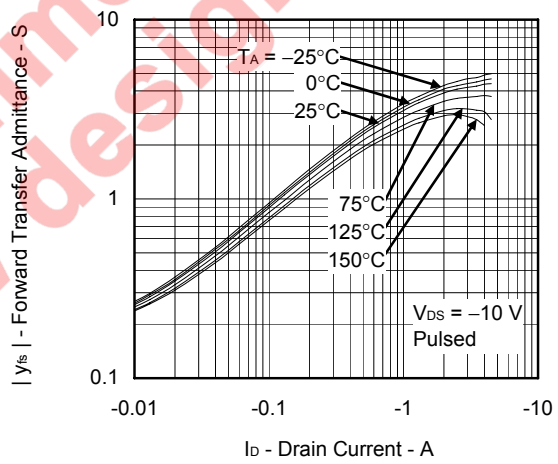
FORWARD TRANSFER CHARACTERISTICS



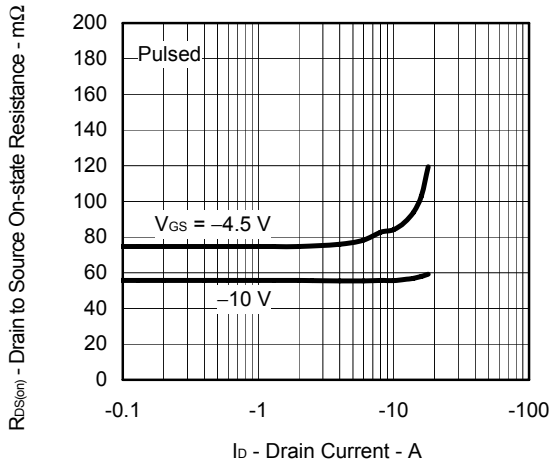
GATE TO SOURCE CUT-OFF VOLTAGE vs. CHANNEL TEMPERATURE



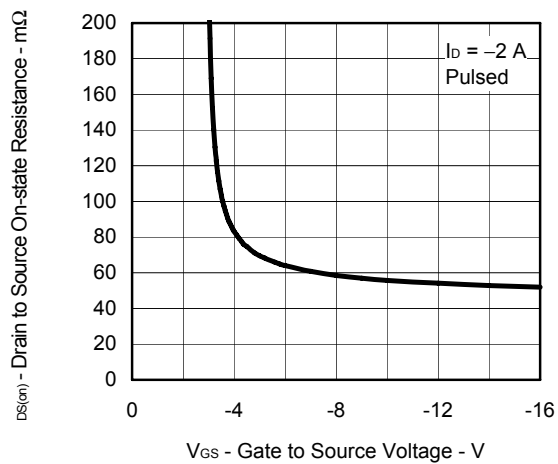
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



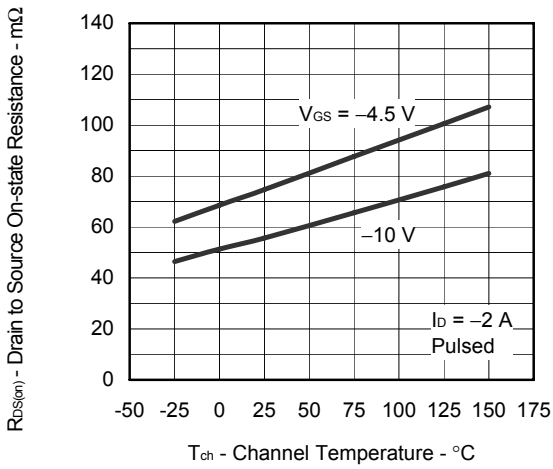
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



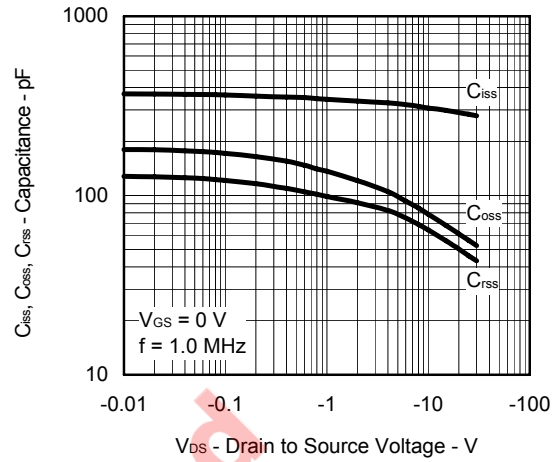
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



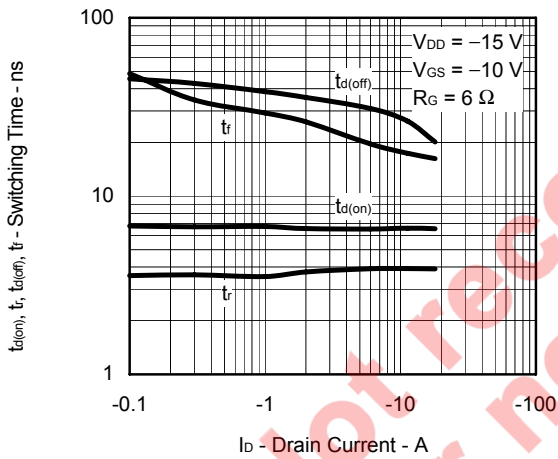
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



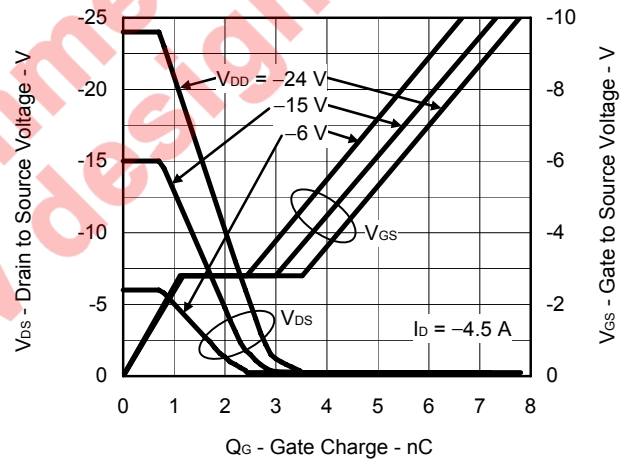
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



SWITCHING CHARACTERISTICS



DYNAMIC INPUT/OUTPUT CHARACTERISTICS



SOURCE TO DRAIN DIODE FORWARD VOLTAGE

